

Application/Control	No.
10/772,318	

Examiner Chen-Wen Jiang Applicant(s)/Patent under Reexamination
BASH ET AL.

Art Unit 3744

				ISSUE	CL	<u> AS</u>	SIF	<b>ICAT</b>	ION							
		ORIGINAL				INTERNATIONAL CLASSIFICATION										
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⊠c	Claims renumbered in the same order as presented by applicant									☐ CPA			☐ T.D.		☐ R.1.47				
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	2			32			62	1		92			122			152			182
	3			33			63	1		93			123			153			183
	4			34			64			94			124			154			184
	5			35			65			95			125			155			185
	6	,		36			66			96			126			156			186
	7			37			67			97			127			157			187
	8			38			68			98			128			158			188
	9			39			69			99			129			159			189
	10			40			70			100			130			160			190
	11			41			71			101			131			161			191
	12			42			72			102			132			162			192
	13			43			73			103			133			163			193
	14			44			74			104			134			164			194
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	17			47			77	]		107			137			167			197
	18			48			78			108			138			168			198
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